



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2813
Examiner: Jack S. J. CHEN

In-Re PATENT APPLICATION Of:

Applicants: Toshikazu MIZUKOSHI

Serial No.: 10/635,506

Filed: August 7, 2003

For: METHOD OF FABRICATING A
SEMICONDUCTOR DEVICE HAVING
TRENCHES

Docket No.: OKI 361

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)
) **INFORMATION DISCLOSURE**
) **STATEMENT WITH**
) **CERTIFICATION**
)
)
)

April 9, 2004

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97 (b)(3), i.e., prior to a First Office Action on the Merits.

Attached are copies of two Japanese publications together with their English-language Abstracts. These documents were all cited in a counterpart application. Also listed for consideration are two U.S. patents corresponding to the two Japanese publications. Any relevance of the Japanese publications can be gleaned from the attached English-language Abstracts or from the listed corresponding U.S. patents. The documents are listed on the attached Form PTO-1449.

It is hereby certified that each item of information contained in the Information Disclosure Statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Information Disclosure Statement.

Consideration of the listed documents is respectfully requested.

Respectfully submitted,

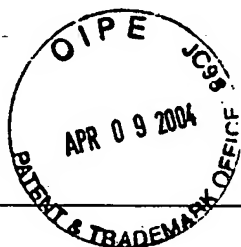
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FORM PTO-1449

INFORMATION DISCLOSURE STATEMENT

Atty. Docket:
OKI 361Application No.:
10/635,506Applicant:
Toshikazu MIZUKOSHIFiling Date:
August 7, 2003Group Art Unit:
2813

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date
	AA	US 6, 599,811 B1	07/29/03	Kazama et al.			
	AB	US 6,566,224 B1	05/20/03	Chang et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Sub-Class	Translation
	AI	JP 11-233614	08/27/99	Japan			Abstract
	AJ	JP 11-097523	04/09/99	Japan			Abstract
	AK						
	AL						
	AM						

OTHER (Including Author, Title, Date, Pertinent Pages, etc.)

	AN	
	AO	

Examiner

Date Considered

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.